

10/529362

Attorney Docket No. 970.1011
JC17 Rec'd PCT/PTO 28 MAR 2005

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of:

In re the Application of 35 U.S.C. §371:

Toshiaki KAKEMURA et al.

Based Upon International Application No.
PCT/JP03/12334

Group Art Unit: Unassigned

International Filing Date: September 26, 2003

Examiner: Unassigned

US Filing Date:

For: THIN FILM FORMING METHOD, THIN FILM FORMING DEVICE, AND THIN FILM
FORMING PROCESS MONITORING METHOD

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
PO Box 1450
Alexandria, VA 22313-1450

Sir:

In accordance with the duty of disclosure provisions of 37 CFR § 1.56, there is hereby provided certain information which the Examiner may consider material to the examination of the subject U.S. patent application. It is requested that the Examiner make this information of record if it is deemed material to the examination of the subject application.

1. Enclosures accompanying this Information Disclosure Statement are:

- 1a. ☒ Form PTO-1449.
- 1b. ☒ Copy(ies) of IDS citation(s), except for U.S. Patents and U.S. Patent Application publications.
- 1c. ☒ Japanese language copy of a communication(s) from a foreign Patent Office or a PCT International Search Report.
- 1d. ☐ English language translation (complete, Abstract or relevant portion(s)) attached to non-English language publications as indicated on the attached Form PTO-1449.
- 1e. ☐ Explanations of Relevancy of References (ATTACHMENT 1(e), hereto) for providing a concise explanation of non-English publications.

2. ☐ In accordance with 37 CFR § 1.98, a concise explanation of what is presently understood to be the relevance of each non-English language publication is

(Check appropriate Items 2a, 2b, 2c and/or 2d)

- 2a. ☐ satisfied for the non-English language publication(s) cited on the enclosed "English language version of the search report or action which indicates the degree of relevance found by the foreign office". (See MPEP § 609, Minimum Requirements for an Information Disclosure Statement, Part A(3): Concise Explanation of Relevance, 8th Ed., Rev. 2)
- 2b. ☐ set forth in the application.
- 2c. ☐ satisfied for the non-English language publication(s) indicated on the attached PTO-1449 as having an English language translation (complete, Abstract or relevant portion(s)) attached thereto.
- 2d. ☐ enclosed as Attachment 1(e), hereto.
3. No admission is made that the information cited in this Statement is, or is considered to be, material to patentability nor a representation that a search has been made (other than search report(s) from a counterpart foreign application or a PCT International Search Report, if submitted herewith). 37 CFR §§ 1.97(g) and (h).

Respectfully submitted,

STAAS & HALSEY LLP

Dated: March 28, 2005
1201 New York Ave., N.W., Suite 700
Washington, D.C. 20005
Telephone: (202) 434-1500
Facsimile: (202) 434-1501

By: David M. Pitcher

David M. Pitcher
Registration No. 25,908

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTORNEY DOCKET NO.

970.1011

APPLICATION NO.

Unassigned

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INFORMATION DISCLOSURE STATEMENT*(Use several sheets if necessary)*

FIRST NAMED INVENTOR

Toshiaki KAKEMURA et al.

FILING DATE

GROUP ART UNIT

Unassigned

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	AA	4,888,199	12/19/89	Felts et al.			
	AB	5,904,952	05/18/99	Lopata et al.			
	AC	5,965,203	10/12/99	Gabric et al.			
	AD						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	TRANSLATION YES NO		ABSTRACT
	AE	EP 0 299 752 A2	01/18/89	Europe	X		
	AF	EP 0 299 754 A2	01/18/89	Europe	X		
	AG	EP 0 469 926 A1	02/05/92	Europe	X		
	AH	EP 0 741 196 A1	11/06/96	Europe		X	
	AI	6-108255	04/19/94	Japan		X	
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	AP	64-87777	03/31/89	Japan		X	
	AQ	2001-220679	08/14/01	Japan		X	
	AR	2 048 168	02/04/92	Canada	X		

EXAMINER**DATE CONSIDERED**

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.